

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	09/585,553	ONO, SHUJI
	<b>Examiner</b>	<b>Art Unit</b>
	Nhan T. Tran	2622

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner